

Notice of References Cited	Application/Control No. 10/029,617	Applicant(s)/Patent Under Reexamination LUTCHE ET AL.	
	Examiner Tilahun B Gesesse	Art Unit 2684	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,491,692	01-1985	Lee, Shan S.	362/24
*	B	US-6,144,863	11-2000	Charron, Didier	455/566
*	C	US-6,771,938	08-2004	Lustila et al.	379/376.01
*	D	US-6,269,256	07-2001	Nakamura, Taisuke	455/567
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.